

# International IR Rectifier

勝特力材料 886-3-5753170  
 胜特力电子(上海) 86-21-34970699  
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PD-95618A

## IRF3007PbF

### Typical Applications

- Industrial Motor Drive

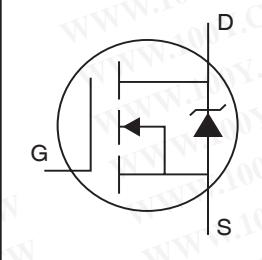
### Features

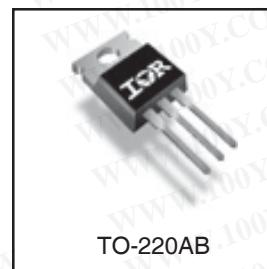
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free

### Description

This design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this HEXFET power MOSFET are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These combine to make this design an extremely efficient and reliable device for use in a wide variety of applications.

### HEXFET® Power MOSFET

	$V_{DSS} = 75V$ $R_{DS(on)} = 0.0126\Omega$ $I_D = 75A$
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TO-220AB

### Absolute Maximum Ratings

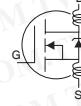
	Parameter	Max.	Units
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Silicon limited)	80	
$I_D @ T_C = 100^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (See Fig.9)	56	A
$I_D @ T_C = 25^\circ C$	Continuous Drain Current, $V_{GS} @ 10V$ (Package limited)	75	
$I_{DM}$	Pulsed Drain Current ①	320	
$P_D @ T_C = 25^\circ C$	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
$V_{GS}$	Gate-to-Source Voltage	$\pm 20$	V
$E_{AS}$	Single Pulse Avalanche Energy ②	280	mJ
$E_{AS}$ (6 sigma)	Single Pulse Avalanche Energy Tested Value ⑦	946	
$I_{AR}$	Avalanche Current ①	See Fig.12a, 12b, 15, 16	A
$E_{AR}$	Repetitive Avalanche Energy ⑥		mJ
$T_J$ $T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting Torque, 6-32 or M3 screw	1.1 (10)	N·m (lb·in)

### Thermal Resistance

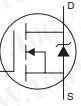
	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.74	
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	°C/W
$R_{\theta JA}$	Junction-to-Ambient	—	62	

# IRF3007PbF

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

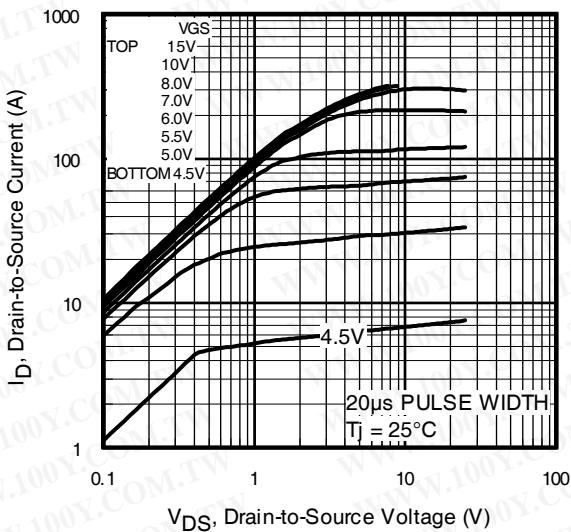
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	75	—	—	V	$V_{\text{GS}} = 0\text{V}$ , $I_D = 250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	—	0.084	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}$ , $I_D = 1\text{mA}$
$R_{\text{DS}(\text{on})}$	Static Drain-to-Source On-Resistance	—	10.5	12.6	$\text{m}\Omega$	$V_{\text{GS}} = 10\text{V}$ , $I_D = 48\text{A}$ ④
$V_{\text{GS}(\text{th})}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{\text{DS}} = 10\text{V}$ , $I_D = 250\mu\text{A}$
$g_{\text{fs}}$	Forward Transconductance	180	—	—	S	$V_{\text{DS}} = 25\text{V}$ , $I_D = 48\text{A}$
$I_{\text{DSS}}$	Drain-to-Source Leakage Current	—	—	20	$\mu\text{A}$	$V_{\text{DS}} = 75\text{V}$ , $V_{\text{GS}} = 0\text{V}$
		—	—	250		$V_{\text{DS}} = 60\text{V}$ , $V_{\text{GS}} = 0\text{V}$ , $T_J = 150^\circ\text{C}$
$I_{\text{GSS}}$	Gate-to-Source Forward Leakage	—	—	200	nA	$V_{\text{GS}} = 20\text{V}$
	Gate-to-Source Reverse Leakage	—	—	-200		$V_{\text{GS}} = -20\text{V}$
$Q_g$	Total Gate Charge	—	89	130	nC	$I_D = 48\text{A}$
$Q_{\text{gs}}$	Gate-to-Source Charge	—	21	32		$V_{\text{DS}} = 60\text{V}$
$Q_{\text{gd}}$	Gate-to-Drain ("Miller") Charge	—	30	45		$V_{\text{GS}} = 10\text{V}$
$t_{\text{d}(\text{on})}$	Turn-On Delay Time	—	12	—	ns	$V_{\text{DD}} = 38\text{V}$
$t_r$	Rise Time	—	80	—		$I_D = 48\text{A}$
$t_{\text{d}(\text{off})}$	Turn-Off Delay Time	—	55	—		$R_G = 4.6\Omega$
$t_f$	Fall Time	—	49	—		$V_{\text{GS}} = 10\text{V}$ ④
$L_D$	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{\text{iss}}$	Input Capacitance	—	3270	—	pF	$V_{\text{GS}} = 0\text{V}$
$C_{\text{oss}}$	Output Capacitance	—	520	—		$V_{\text{DS}} = 25\text{V}$
$C_{\text{rss}}$	Reverse Transfer Capacitance	—	78	—		$f = 1.0\text{MHz}$ , See Fig. 5
$C_{\text{oss}}$	Output Capacitance	—	3500	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 1.0\text{V}$ , $f = 1.0\text{MHz}$
$C_{\text{oss}}$	Output Capacitance	—	340	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 60\text{V}$ , $f = 1.0\text{MHz}$
$C_{\text{oss eff.}}$	Effective Output Capacitance ⑤	—	640	—		$V_{\text{GS}} = 0\text{V}$ , $V_{\text{DS}} = 0\text{V}$ to $60\text{V}$

## Source-Drain Ratings and Characteristics

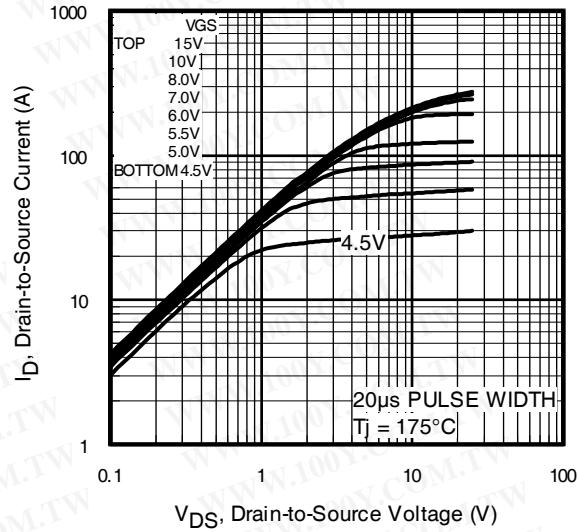
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	80 ⑥	A	MOSFET symbol showing the integral reverse p-n junction diode. 
$I_{\text{SM}}$	Pulsed Source Current (Body Diode) ①	—	—	320		
$V_{\text{SD}}$	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}$ , $I_S = 48\text{A}$ , $V_{\text{GS}} = 0\text{V}$ ④
$t_{rr}$	Reverse Recovery Time	—	85	130	ns	$T_J = 25^\circ\text{C}$ , $I_F = 48\text{A}$ , $V_{\text{DD}} = 38\text{V}$
$Q_{rr}$	Reverse Recovery Charge	—	280	420	nC	$dI/dt = 100\text{A}/\mu\text{s}$ ④
$t_{\text{on}}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_s + L_D$ )				

### Notes:

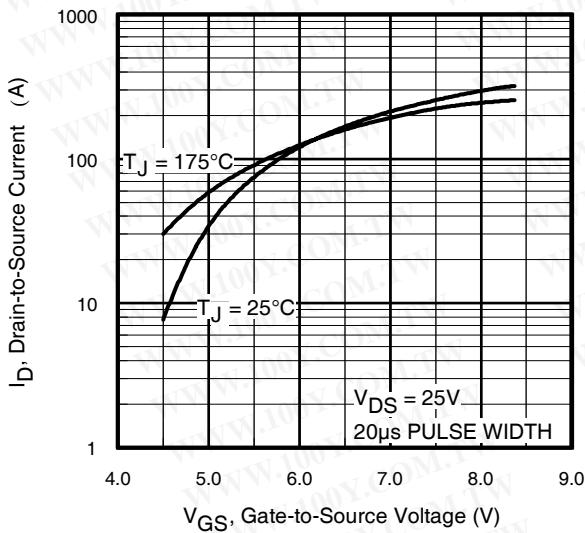
- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11).
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.24\text{mH}$   
 $R_G = 25\Omega$ ,  $I_{AS} = 48\text{A}$ ,  $V_{\text{GS}}=10\text{V}$  (See Figure 12).
- ③  $I_{\text{SD}} \leq 48\text{A}$ ,  $di/dt \leq 330\text{A}/\mu\text{s}$ ,  $V_{\text{DD}} \leq V_{(\text{BR})\text{DSS}}$   
 $T_J \leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{\text{oss eff.}}$  is a fixed capacitance that gives the same charging time as  $C_{\text{oss}}$  while  $V_{\text{DS}}$  is rising from 0 to 80%  $V_{\text{DSS}}$ .
- ⑥ Limited by  $T_{J\text{max}}$ , see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- ⑦ This value determined from sample failure population. 100% tested to this value in production.



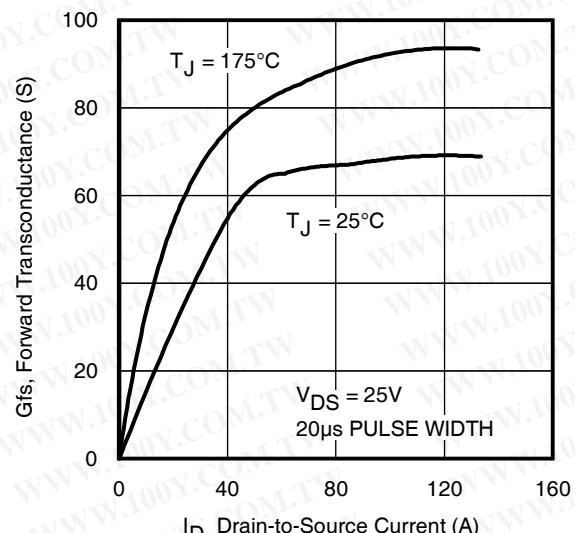
**Fig 1.** Typical Output Characteristics



**Fig 2.** Typical Output Characteristics

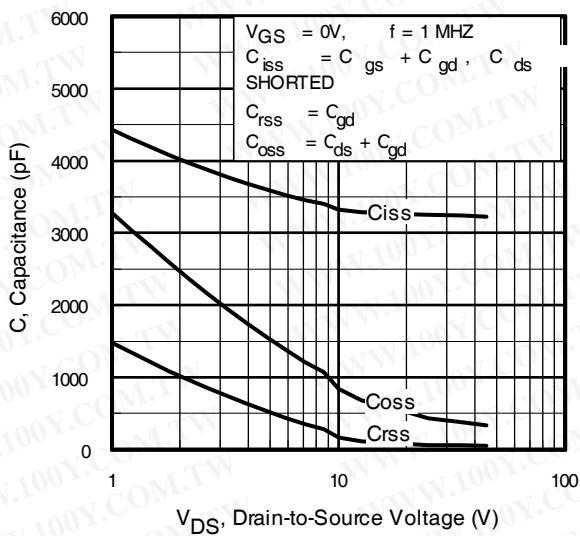


**Fig 3.** Typical Transfer Characteristics

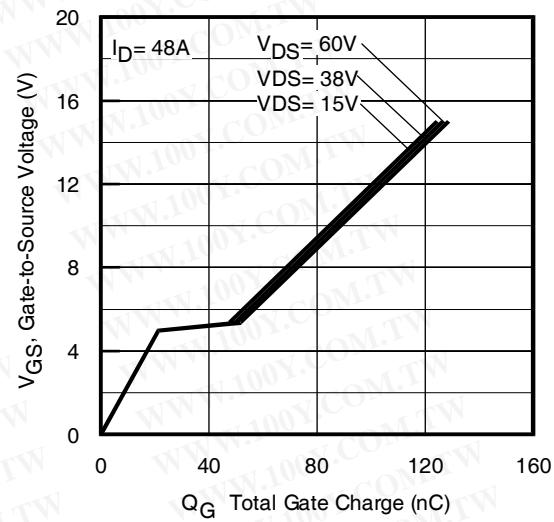


**Fig 4.** Typical Forward Transconductance Vs. Drain Current

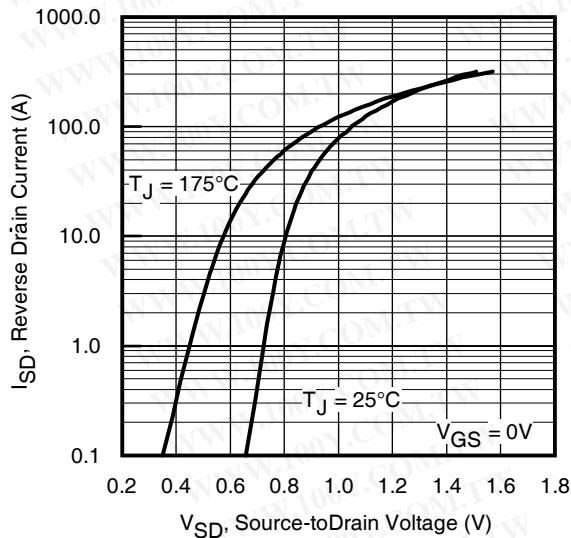
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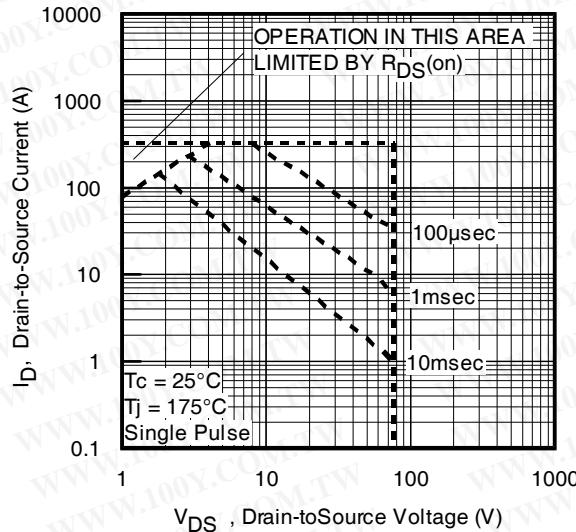
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



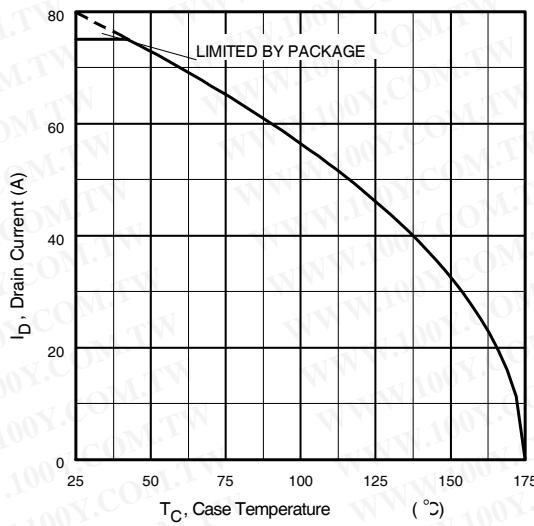
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



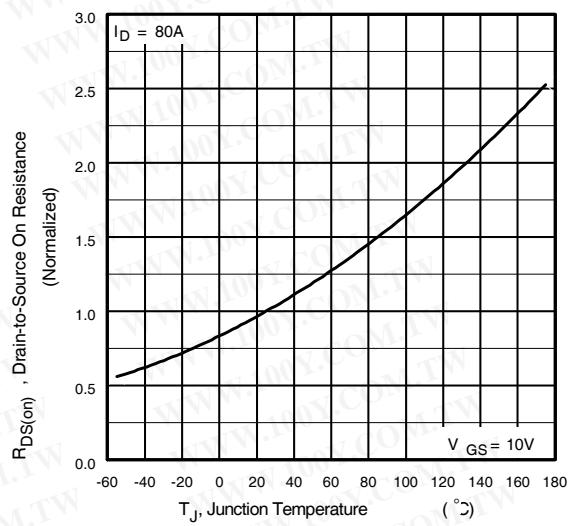
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



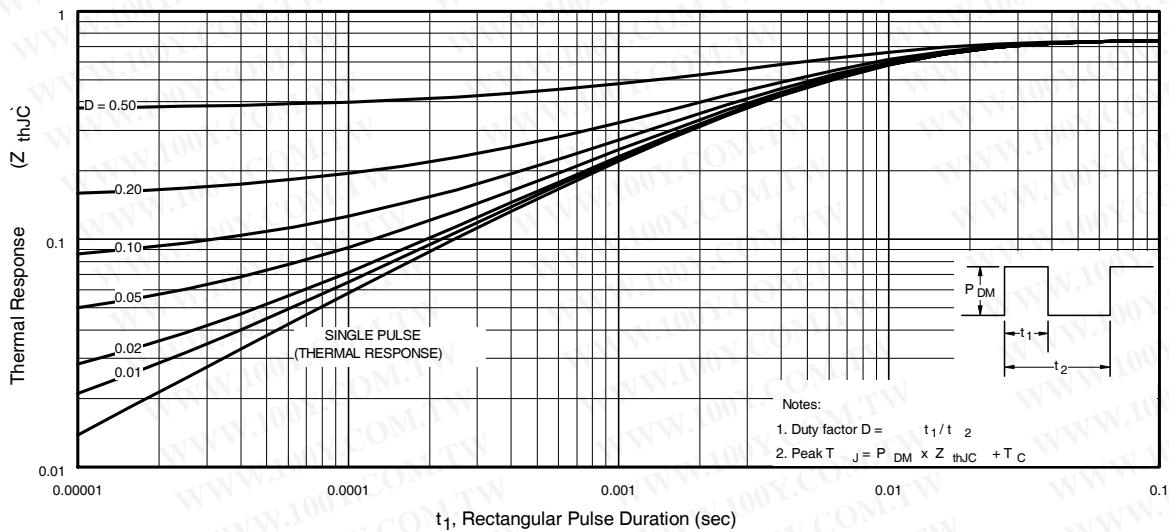
**Fig 8.** Maximum Safe Operating Area



**Fig 9.** Maximum Drain Current Vs.  
Case Temperature

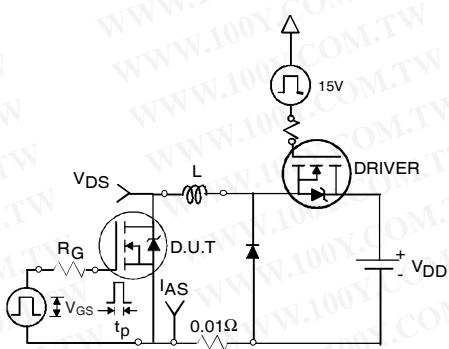


**Fig 10.** Normalized On-Resistance  
Vs. Temperature

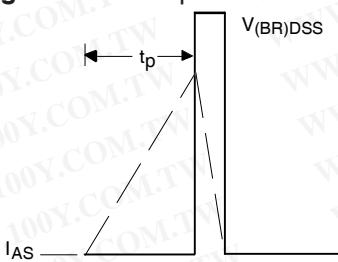


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

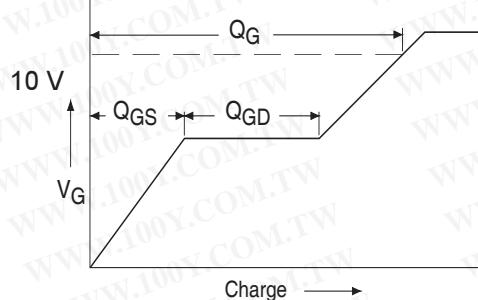
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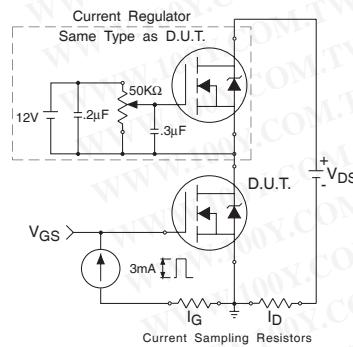
**Fig 12a.** Unclamped Inductive Test Circuit



**Fig 12b.** Unclamped Inductive Waveforms

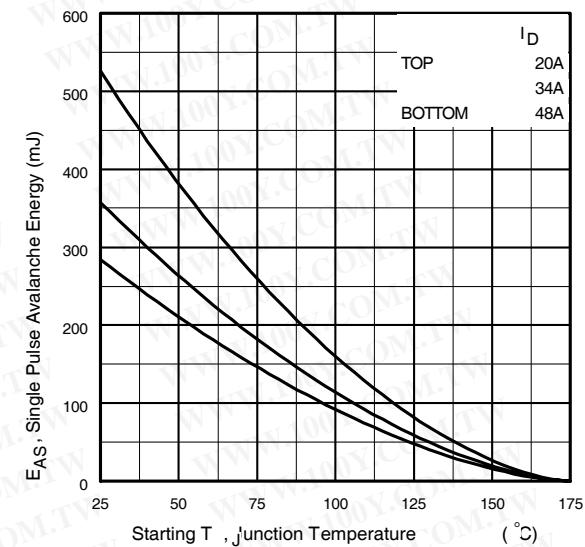


**Fig 13a.** Basic Gate Charge Waveform

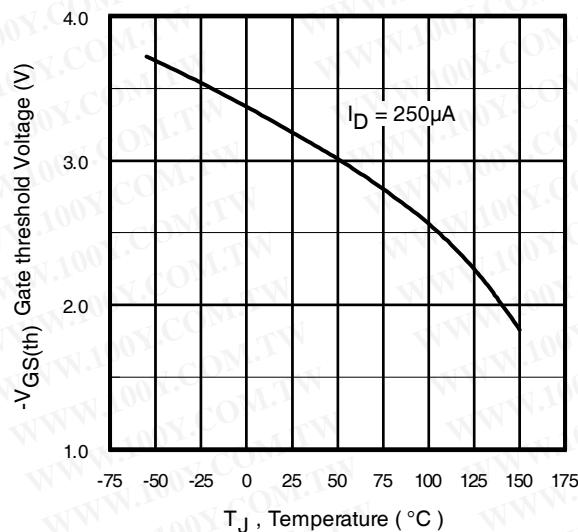


**Fig 13b.** Gate Charge Test Circuit

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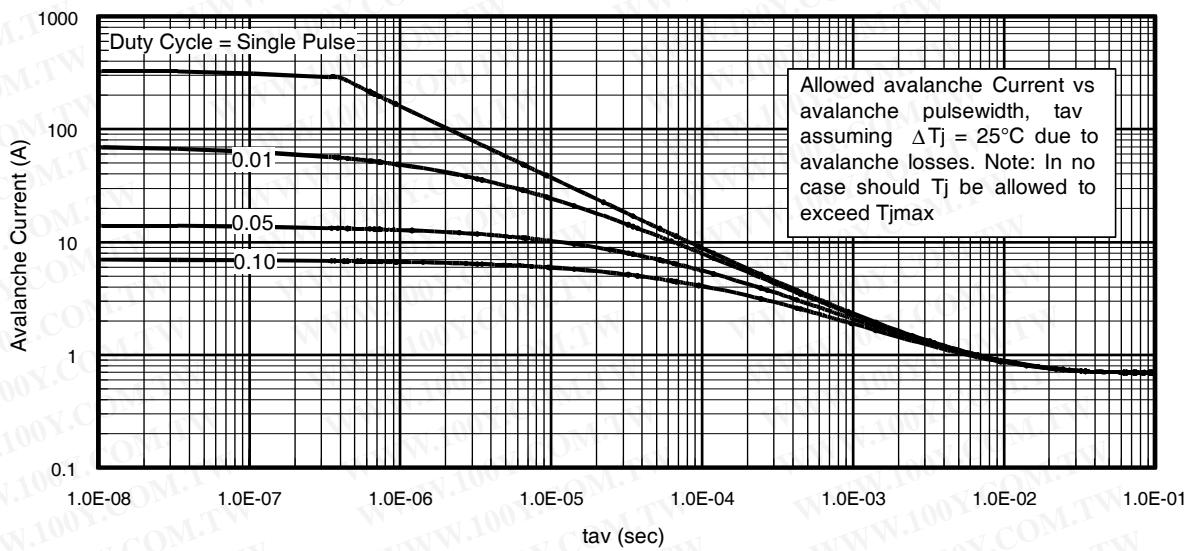


**Fig 12c.** Maximum Avalanche Energy Vs. Drain Current

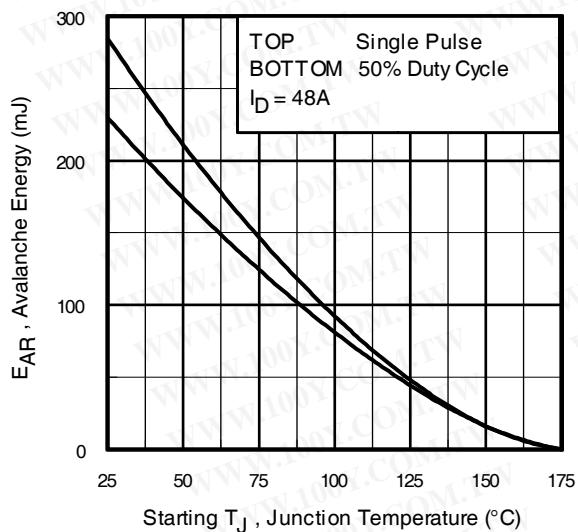


**Fig 14.** Threshold Voltage Vs. Temperature

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**Fig 15.** Typical Avalanche Current Vs.Pulsewidth



**Fig 16.** Maximum Avalanche Energy Vs. Temperature

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**Notes on Repetitive Avalanche Curves , Figures 15, 16:  
 (For further info, see AN-1005 at [www.irf.com](http://www.irf.com))**

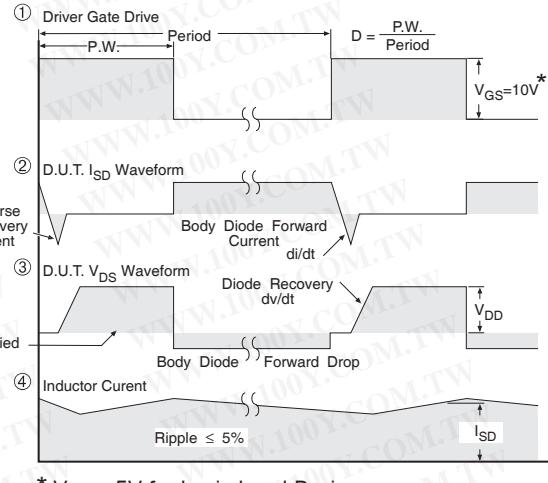
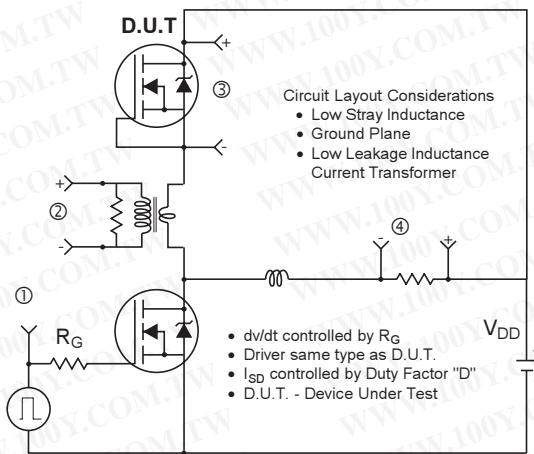
1. Avalanche failures assumption:  
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as  $25^\circ\text{C}$  in Figure 15, 16).
- $t_{av}$  = Average time in avalanche.
- D = Duty cycle in avalanche =  $t_{av} \cdot f$
- $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see figure 11)

$$P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$$

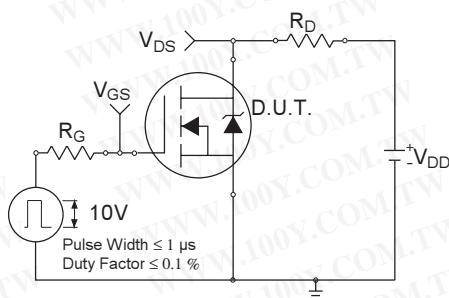
$$I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$$

$$E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$$

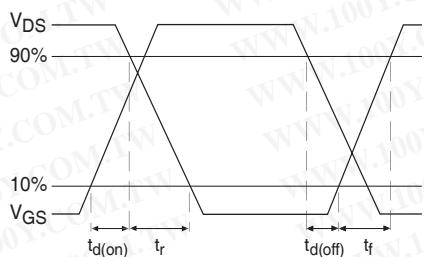
# IRF3007PbF



**Fig 17.** Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



**Fig 18a.** Switching Time Test Circuit



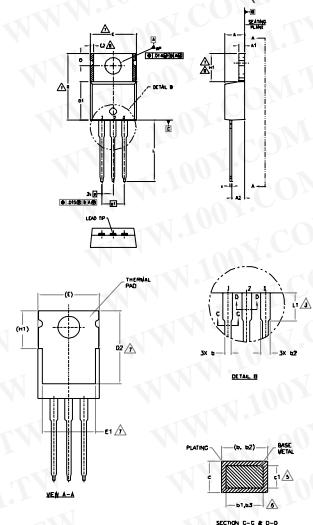
**Fig 18b.** Switching Time Waveforms

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**IR** Rectifier

## TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



NOTES:  
 1. DIMENSIONS AND TOLERANCES AS PER JEDEC TA-102.  
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).  
 3. LEAD DIMENSIONS ARE FROM FLAT (CROPPED) TO FLAT.  
 4. LEAD THICKNESS IS .005 (.0002) INCHES. LEAD FLASH SHALL NOT EXCEED .001 (.025) MM FOR THESE DIMENSIONS.  
 5. DIMENSION A IS FROM FLAT (CROPPED) TO PLASTIC BODY.  
 6. DIMENSION B IS FROM FLAT (CROPPED) TO PLASTIC BODY.  
 7. CONTROLLING DIMENSION - INCHES.  
 8. DIMENSION C IS FROM FLAT (CROPPED) TO FLAT.  
 9. OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (mm) AND B2 (mm).  
 (mm) DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE.

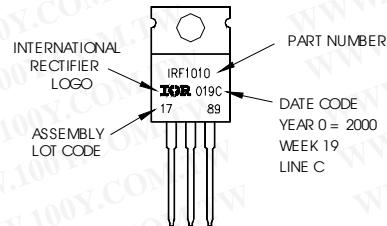
SYMBOL	DIMENSIONS				NOTES
	MM	INCHES	MM	INCHES	
A	5.56	.219	.140	.006	
A1	5.51	.217	.136	.005	
A2	2.03	.079	.080	.003	
b	0.38	.015	.015	.0005	
b1	0.36	.014	.031	.001	
b2	1.14	.045	.045	.001	5
b3	1.14	.045	.045	.001	5
c	3.56	.140	.261	.010	
c1	0.36	.014	.014	.0005	
c2	14.22	.561	.560	.022	4
d	0.36	.014	.014	.0005	
D2	11.69	.459	.460	.018	7
e	9.85	.387	.380	.015	
E	6.86	.270	.270	.010	7
F	1.27	.050	.127	.005	8
G	2.44	.096	.244	.010	
H	0.96	.038	.270	.010	1.8
I	12.70	.499	14.73	.580	
J	5.56	.219	.140	.006	3
K	2.44	.096	.244	.010	
Q	2.54	.100	.242	.009	.355

## IRF3007PbF

### TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010  
 LOT CODE 1789  
 ASSEMBLED ON WW 19, 2000  
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position  
 indicates "Lead-Free"



TO-220AB package is not recommended for Surface Mount Application

#### Notes:

- For an Automotive Qualified version of this part please see <http://www.irf.com/product-info/auto/>
- For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Data and specifications subject to change without notice.  
 This product has been designed and qualified for the Industrial market.  
 Qualification Standards can be found on IR's Web site.

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**IR** Rectifier

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 TAC Fax: (310) 252-7903

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